



PRELIMINARY DATA SHEET

CCD595
9216 x 9216 Pixel Image Area
Full Frame CCD Image Sensor

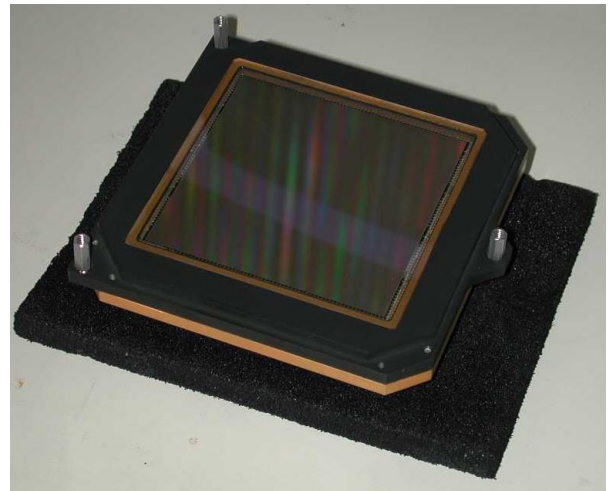
FEATURES

- 9216 x 9216 Full Frame CCD Array
- 8.75 μm x 8.75 μm Pixels
- 80.64mm x 80.64mm Image Area
- 100% Fill Factor
- Non Multi-Pinned Phase (MPP) Operation
- 8 Outputs (4 on each side)
- Readout Noise Less Than 30 e⁻ at 100MHz (25MHz x 4)

GENERAL DESCRIPTION

The CCD595 is a 9216 x 9216 active element solid state Charge Coupled Device (CCD) Full Frame sensor. The CCD is intended for advanced scientific, space, and aerial reconnaissance applications. The CCD595 is organized as an array of 9216 horizontal by 9216 vertical imaging elements. The pixel pitch is 8.75 μm with a 100% fill factor. Three-phase clocking is employed in the imaging area with two-phase clocking in the serial readout registers. Image readout is performed via 4 serial registers containing 19 isolation rows between imaging and readout sections. The imaging array can be clocked unidirectional (4-output configuration) or bi-directional (8-output configuration). The imaging area segments are split in mid-array for the latter configuration. To maximize the exposure/readout cycle rate, concurrent array and serial register clocking is utilized. Fast transfer clocking between the array and serial registers is accomplished with strapped transfer gates that load each line in less than 5 microseconds.

The output circuit architecture features eight (four active, eight optional) three stage source follower readouts. The nominal read noise of the output amplifiers is less than 25 electrons at 25MHz. The combined data rates for 4 and 8 output configurations are 100MHz and 200MHz respectively. Internal temperature and humidity sensors are also located near the FPA for external monitoring.



The top of the package has an optical window over the CCD active area. The CCD595 is mounted in an environmentally sealed enclosure containing the CCD array with thermoelectric coolers for controlling the operating temperature of the array.

Pinouts are provided on three sides for electrical connections (4-output configuration). The package base serves as the heat sink interface for thermal management. A mounting flange at the package rim is used as a Z-axis reference datum for the planarization of the CCD focal plane with external optics.

DC OPERATING CHARACTERISTICS

SYMBOL	PARAMETER	RANGE			UNIT	REMARKS
		MIN	NOM	MAX		
V _{DD}	DC Supply Voltage	18.0	20.0	23.0	V	
V _{RD}	Reset Drain Voltage	14.0	17.0	20.0	V	
V _{OG}	Output Gate Voltage	0.0	1.0	5.0	V	
V _{SS}	Substrate Ground		0.0		V	
V _{odc}	Output DC Level	VRD-5		VRD-4	V	
Z	Suggested Load Resistor	0.8	1.0	1.8	K ohms	

TYPICAL CLOCK VOLTAGES

SYMBOL	PARAMETER		HIGH	LOW	UNIT	REMARKS
V $\phi_{H(1,2)}$, ϕ_{SG}	Horizontal Transport Clock Voh Max-Min		+7.5 +10	-7.5	V V	+4.5, -0.5 Typical
V $\phi_{V(1,2,3)}$	Vertical Transport Clocks		+8.0	-10.0	V	+5, -10 V Typical
V ϕ_R	Reset Gate Clock		+15.0	0.0	V	+2.0 +8.0 V Typical
V $\phi_{VTG(2,3)}$	Array Transfer Gate Clock		+8.0	-10.0	V	+5, -10 Typical
C $\phi_{V(1,2,3)}$	Vertical Array Gates Cap. (per ϕ_V)	A ₁ A ₂ A ₃	47 86 109	30 38 31	nF	Min @ +10V Max @ -10V
C $\phi_{VTG_{2,3}}$	Array Transfer Gate Cap. (per pin)	TG ₂ TG ₃	200 200	150 150	pF	Min @ +10V Max @ -10V
C $\phi_H(1,2)$	Horizontal Transfer Gate Cap. (per ϕ_H)	S ₁ S ₂	65 76		pF	Min @ +10V Max @ -10V
C ϕ_H	Horizontal Transfer Gate Cap. (per pin)	S ₁ S ₂	65 76		pF	Min @ +10V Max @ -10V

Note 1: ϕ_H = 400 pF, ϕ_V = 60,000 pF. All clock rise and fall times should be > 10 ns.

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PERFORMANCE SPECIFICATIONS

SYMBOL	PARAMETER	RANGE			UNIT	REMARKS
		MIN	NOM	MAX		
V_{sat}	Saturation Output Voltage	350	600	800	mV	Note 1
Q_{sat}	Full Well Capacity (98% of Pixels)	70,000			e-	Note 1
S_v	Output Amp Sensitivity		8.0		$\mu V/e^-$	
H_{sat}	Horizontal Register Capacity		130,000		e-	
PRNU	Photo Response Non-Uniformity, Peak-to-Peak			5	% V_{SAT}	Note 2
DSNU	Dark Signal Non-Uniformity (RMS)			5.0	mV	Note 3
DC	Average Dark Current			0.5	nA/cm ²	Note 3
QE_A	Average Quantum Efficiency (550 – 800 μm)	0.35				
MTF	MTF at Nyquist	50%				Note 4
V_{cte}	Vertical Transfer Efficiency	0.999995				Per Transfer (each phase) Note 2
H_{cte}	Horizontal Charge Transfer Efficiency	0.999995				Per Transfer (each phase) Note 2
NE	Total Read Noise Electrons			30	e-rms	Less Shot Noise Note 6
f_{MAX_H}	H Clock Frequency			25	MHz	
PD	Power Dissipation On Chip			2.9	W	At 25MHz each register

Note 1: Minimum output voltage and/or well capacity is achieved operating in standard test condition mode and is the level above which saturation non-linearity of 50% from best straight line fit occurs.

Note 2: Measured at approximately 50% V_{sat} .

Note 3: Value shown is for 15°C.

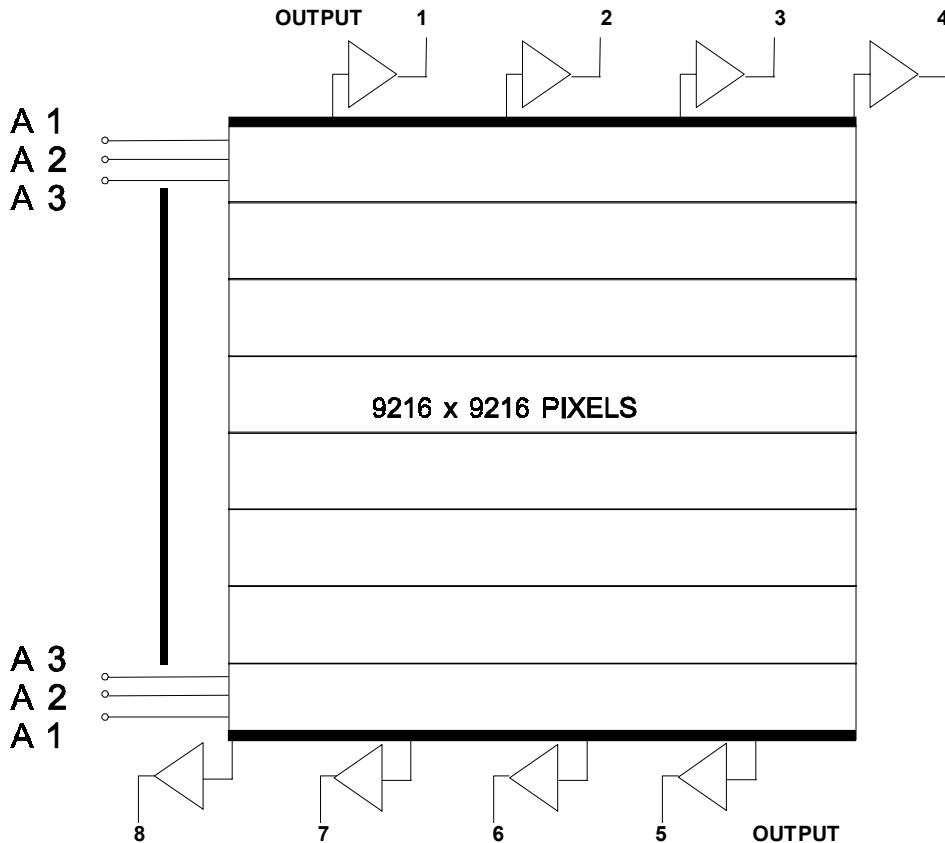
Note 4: Measured at the format center with 2854K tungsten source and Schott OG550 filter, 3mm thick.

Note 5: Standard test conditions are non-MPP clocks and DC operating voltages with 25MHz serial output rate/port.

Note 6: Measured in dark with correlated double sampling of amplifier output signal.

READOUT AMPLIFIER CONFIGURATION

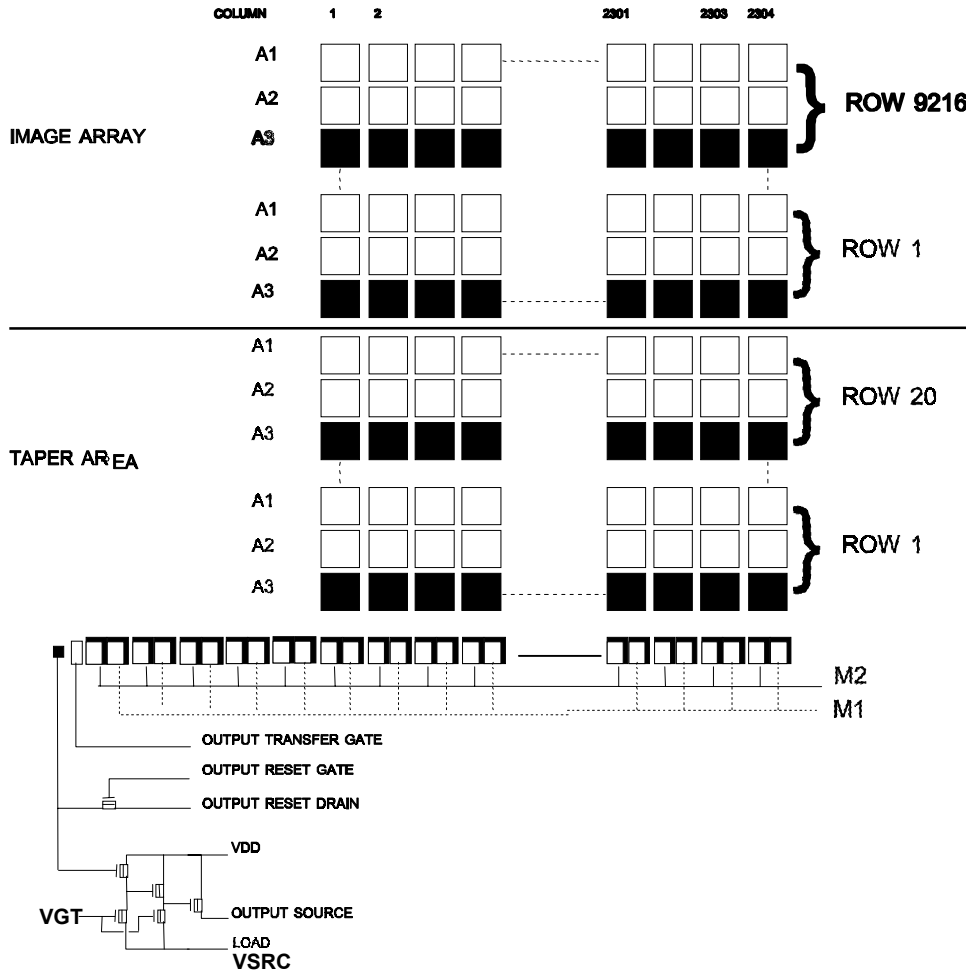
The CCD595 readout structure is shown in the diagram below. Array to serial register transfer gates are not shown.



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SINGLE OUTPUT SECTION DIAGRAM

A Single Section of the CCD595 is shown below. The 20 Taper Rows include a single row of Transfer Gates nearest the serial readout register.



COSMETIC GRADING

Device grading helps to establish a ranking for the image quality that a CCD will provide. Blemishes are characterized as spurious pixels exceeding 10% of Q_{SAT} with respect to neighboring elements. Blemish content is determined in the dark, at various illumination levels and at different operating temperatures.

The CCD595 is available in different grades, as well as custom selected grades. Consult Sales representative for available grading information and custom selections.

WARRANTY

Within twelve months of delivery to the end customer, Fairchild Imaging will repair or replace, at our option, any Fairchild Imaging camera product if any part is found to be defective in materials or workmanship. Contact Customer Service for assignment of warranty return number and shipping instructions to ensure prompt repair or replacement.

CERTIFICATION

Fairchild Imaging certifies that all products are carefully inspected and tested at the factory prior to shipment and will meet all requirements of the specifications under which it is furnished.

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